

Quality Control in the Module Production

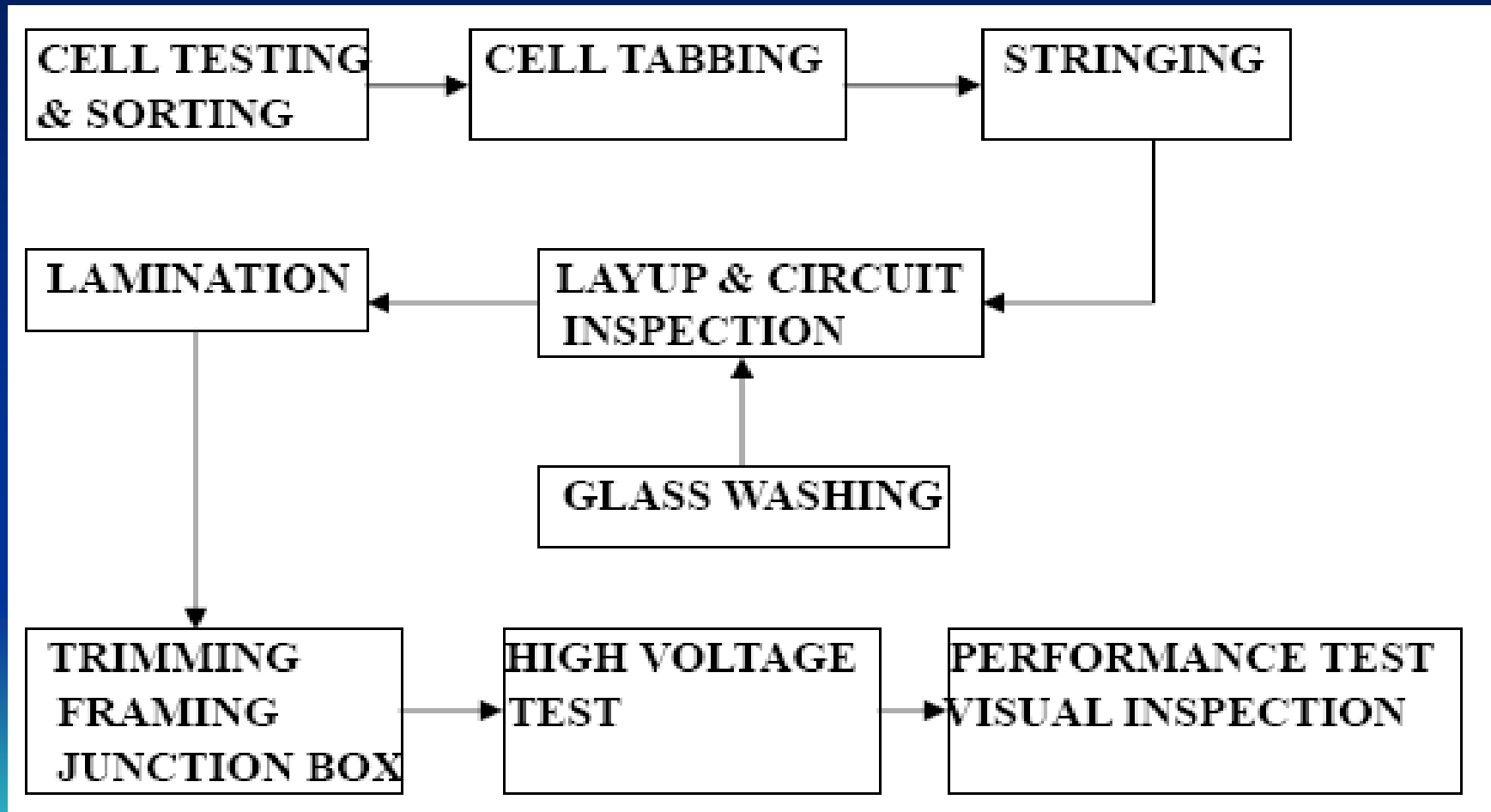
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一、 Process sequence of crystalline silicon solar module



The general standard for solar modules


- (1) Visual inspection
- (2) Insulation test
- (3) Performance test
- (4) Energy production forecast
- (5) Reliability (30 years)

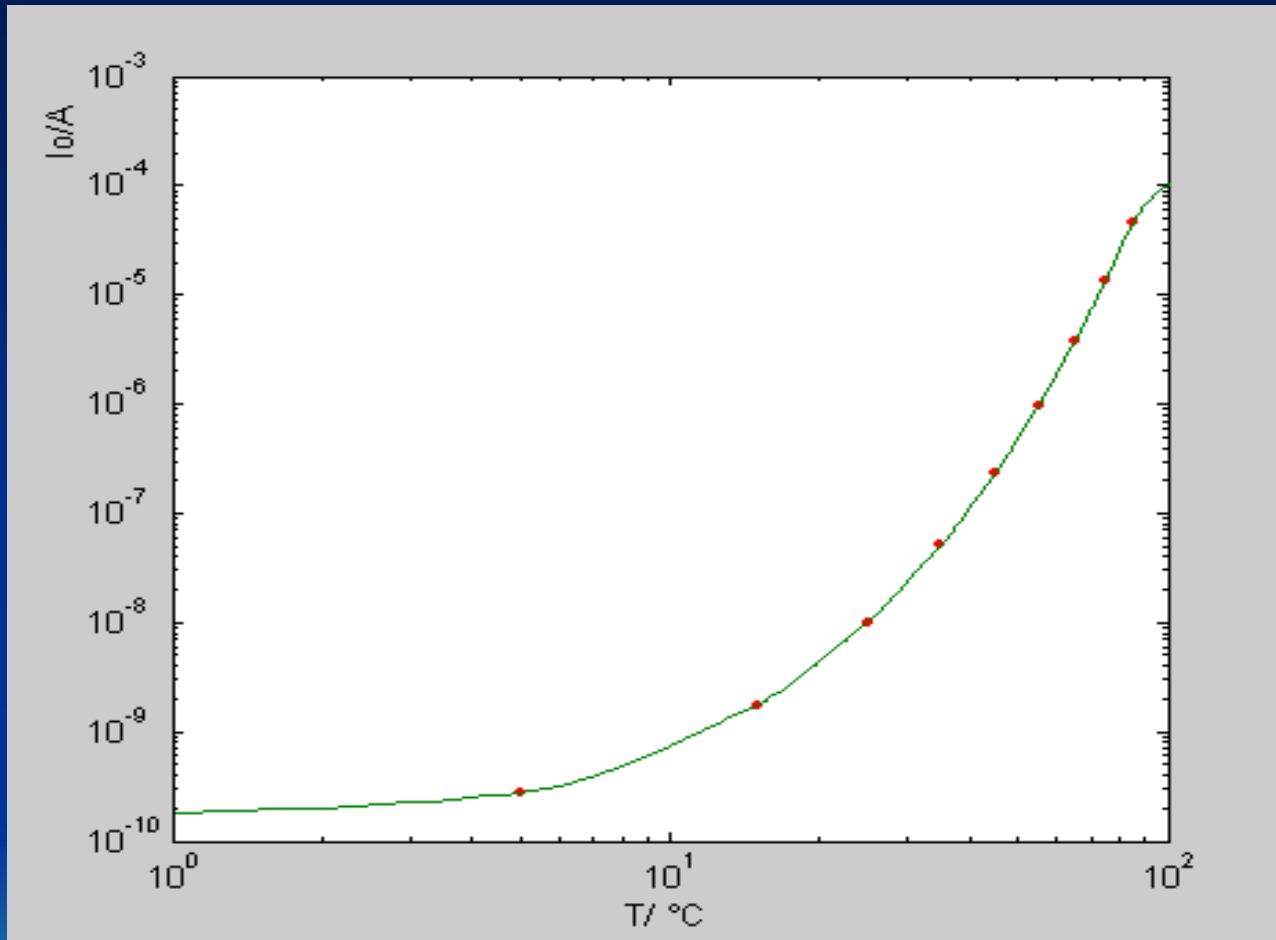
For module factory, system builder and user,
The reliability of modules is very important, the
reliability influence cost payback time (10–12 years
cost payback period)



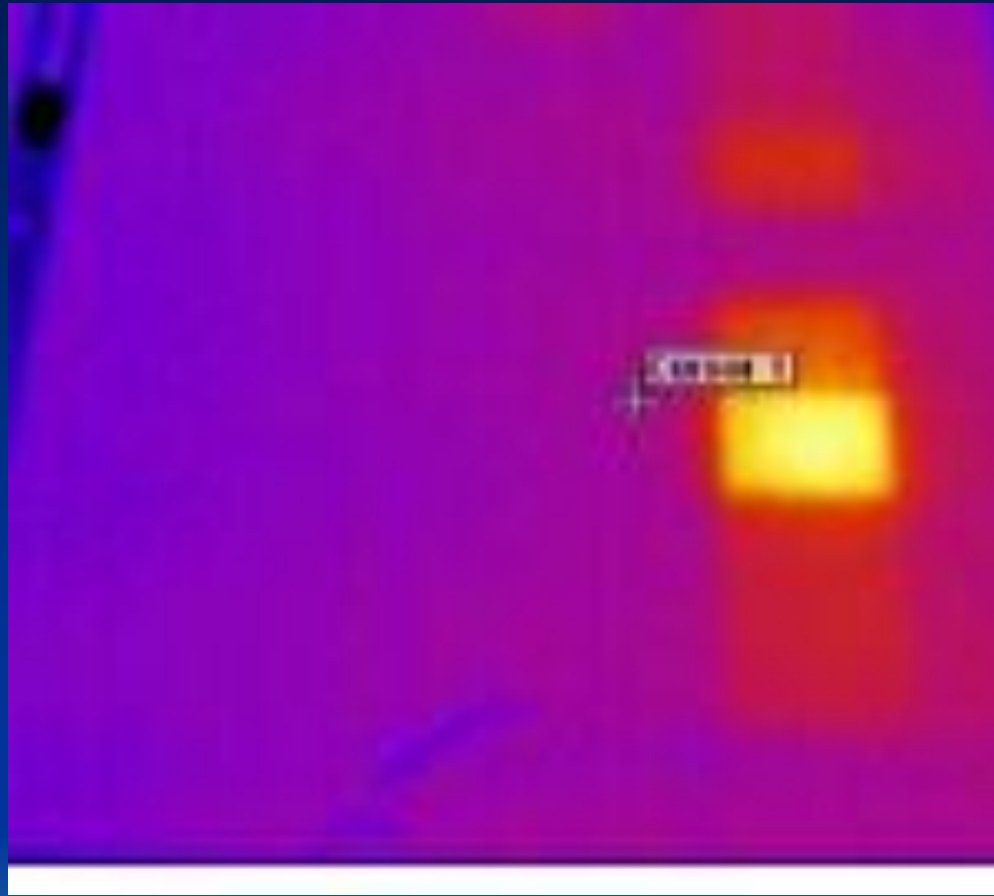
二、IQC

1 Cell testing and sorting

- (1) Efficiency under STC (very narrow efficiency classes)
 - (2) Current measurement at 0.5V under STC (I-V curve step)
 - (3) Current measurement at 0.5V under Non-STC
 - (4) Shunt resistance testing ($1500\Omega \cdot \text{cm}^2$)
 - (5) Reverse current testing
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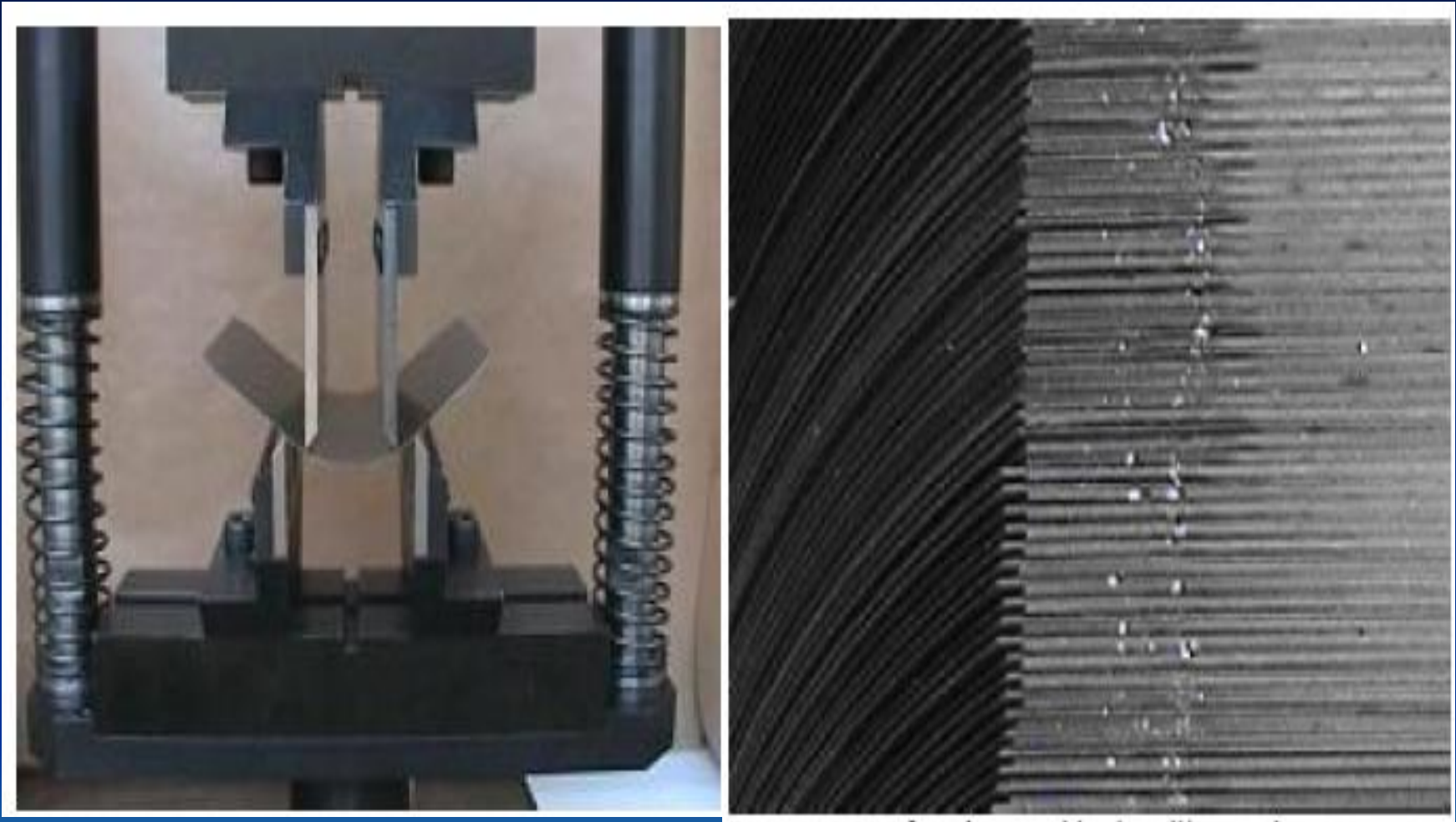
Saturation versus temperature



Effect of reverse current on module

- (6) Micro-crack check-up
- (7) Colour sorting (LC, MC, DC)
- (8) Mechanical conformity (Avoidance of chipping, bowing, thickness variance and other off specs)






Micro-crack propagation (from E.Cereceda, et al.22nd EPSEC)

2 EVA

- (1) transparency(91%) and anti-browning
- (2) EVA and glass peel strength, EVA and TPT peel strength (not less than 20N/cm)
- (3) Not reaction to edge sealant
- (4) water vapor transmission (0.1wt%)
- (5) Crosslinking agent

3 TPT

- (1) TPT and EVA peel strength (not less than 20N/cm)
 - (2) Peel strength of layers (not less than 4N/cm)
 - (3) Breakdown voltage(18KV)
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4 Junction box

- (1) Electrical contact
- (2) heat sink
- (3) Strength of adhesive
- (4) Aging of junction box

5 Aluminium frame

- (1) Stability of performance
- (2) Strength



4 Glass

(1) Flat glass——Textured low iron glass——coated glass

(2) Transparency

(3) Absorbing UV light

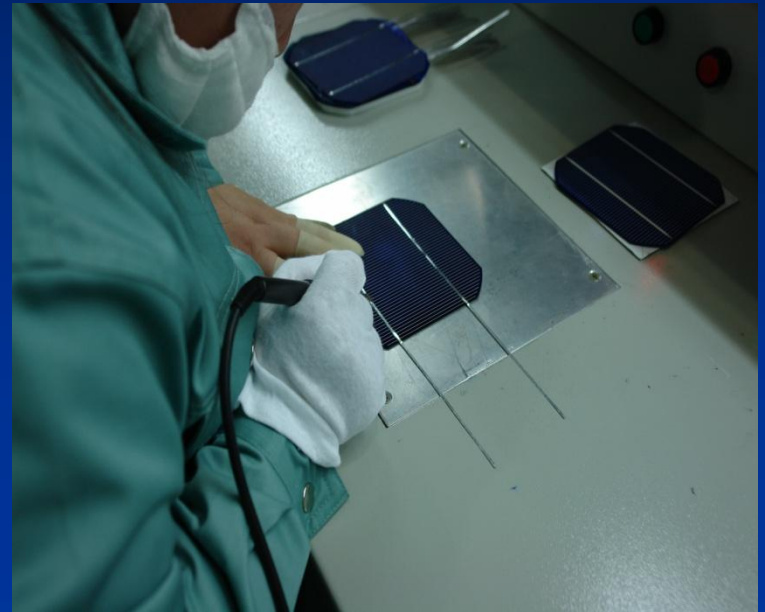
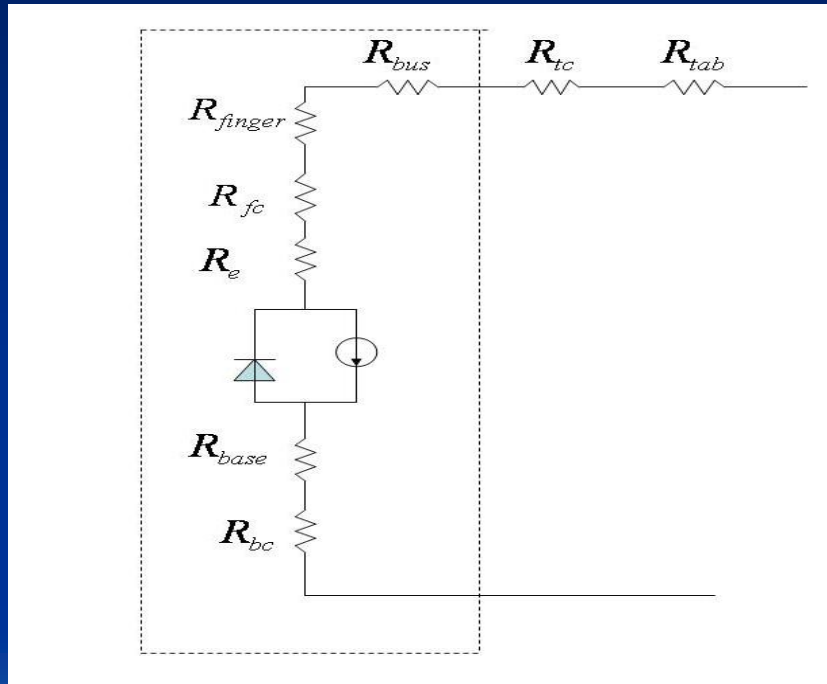
(4) Safety

(5) Glass and EVA peel strength

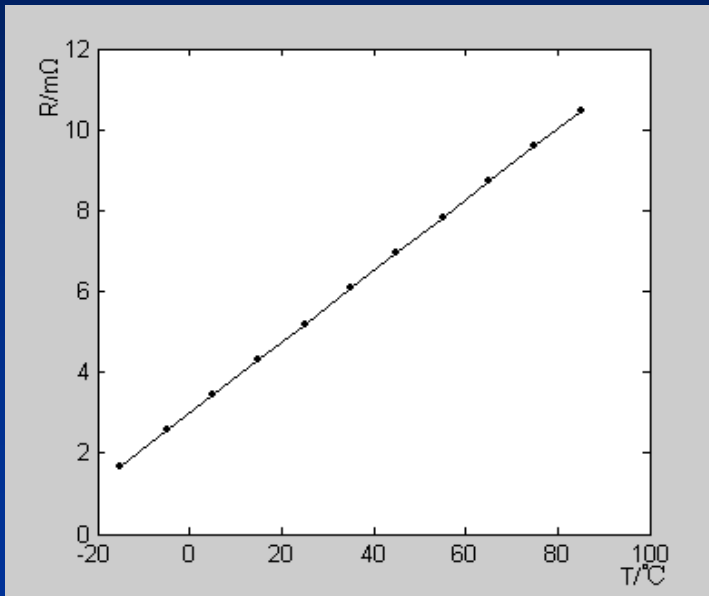


三、IPQC

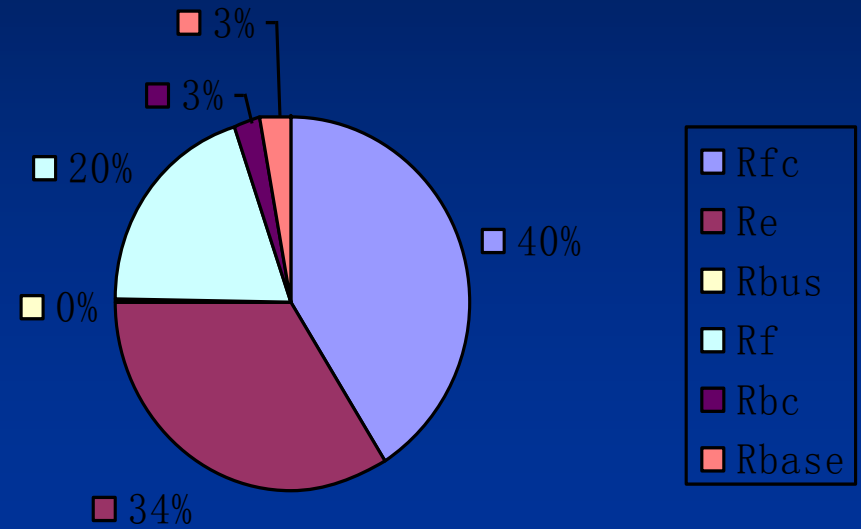
1 Cell tabbing



$$R_{tab} = \rho_{tab} \frac{L}{w_{bus} h_{tab}} \quad R_{tc} = \frac{R_{solder}}{w_{bus} \times L}$$



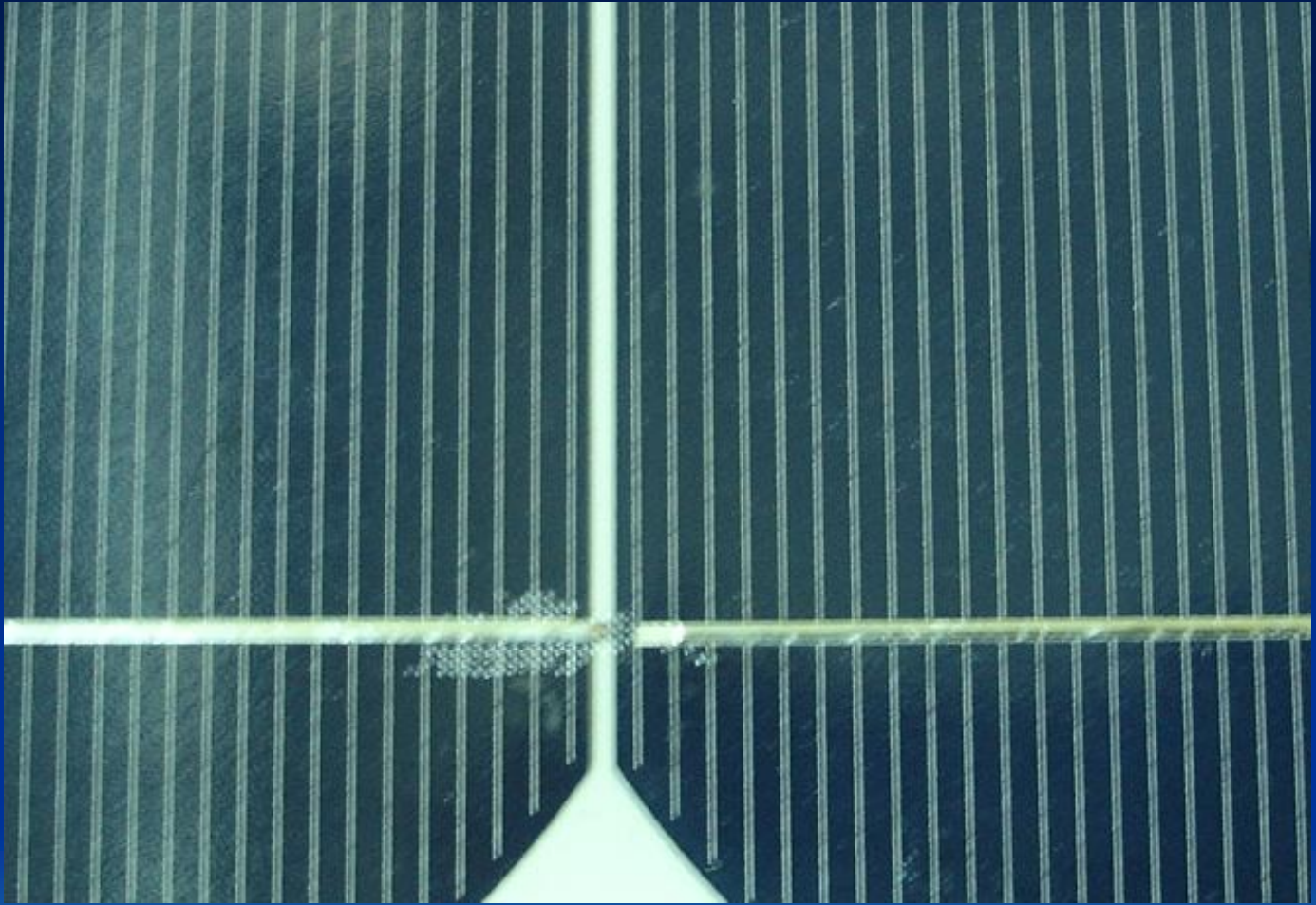
Series resistance versus temperature



Distribution of cell series resistance

- (1) The solder contact resistance lie between $20-80\mu\Omega\text{cm}^2$, alloy percentage $:\gt 80\%$
- (2) Busbar peel strength not less than $(0.4\text{N}/\text{mm}^2)$
- (3) Pre-bending of SnPb coated copper stripe
- (4) Flux (safety, white spot)
- (5) Low stress soldering, breakage rate and latent crack





White spot induced by flux

2 Cell stringing



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